TOSHIBA BiCD Integrated Circuit Silicon Monolithic

TB62211FNG

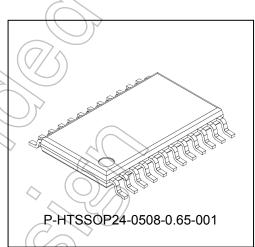
BiCD Constant-Current Two-Phase Bipolar Stepping Motor Driver IC

The TB62211FNG is a two-phase bipolar stepping motor driver using a PWM chopper controlled by clock input.

Fabricated with the BiCD process, the TB62211FNG is rated at 40 V/1.0 A. The on-chip voltage regulator allows control of a stepping motor with a single $V_{\rm M}$ power supply.



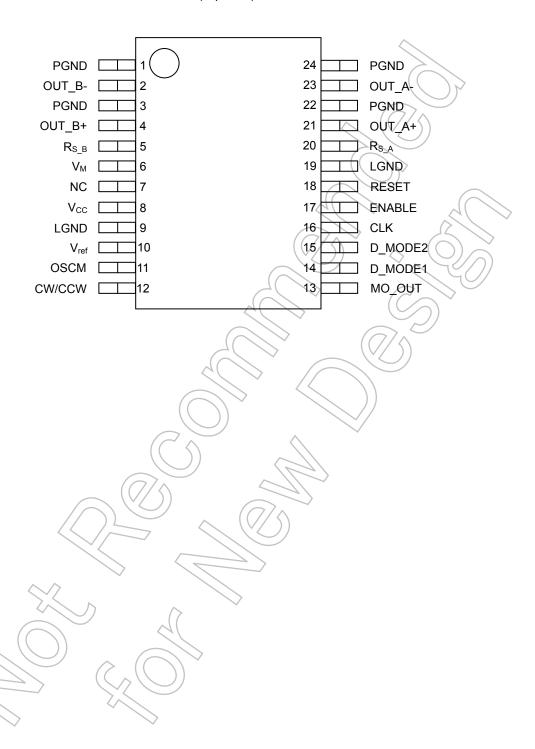
- · Bipolar stepping motor driver
- PWM constant-current drive
- · Clock input control
- Allows two-phase, 1-2-phase and W1-2 phase excitations.
- BiCD process: Uses DMOSFETs as output power transistors.
- High voltage and current : 40 V/1.0 A (absolute maximum ratings)
- Thermal shutdown (TSD), Over current detection (ISD), and Power-on resets (PORs)
- Package: P-HTSSOP24-0508-0.65-001



Wight: 0.1 g (typ.)

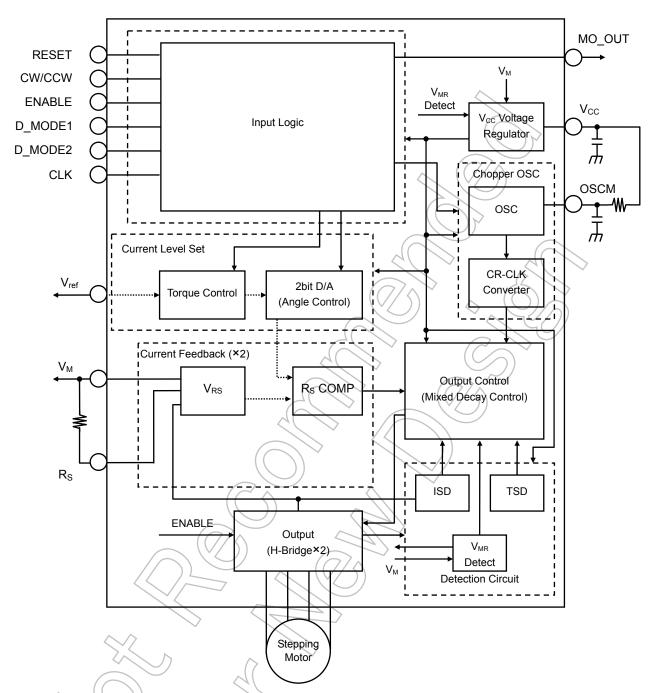
Pin Assignment

(Top View)



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Block Diagram



In the block diagram, part of the functional blocks or constants may be omitted or simplified for explanatory purposes.

Note: All the grounding wires of the TB62211FNG must run on the solder mask on the PCB and be externally terminated at only one point. Also, a grounding method should be considered for efficient heat dissipation. Careful attention should be paid to the layout of the output, V_M and GND traces, to avoid short-circuits across output pins or to the power supply or ground. If such a short-circuit occurs, the TB62211FNG may be permanently damaged. Also, utmost care should be taken for pattern designing and implementation of the TB62211FNG since it has the power supply pins (V_M , R_{S_A} , R_{S_B} , OUT_A+ , OUT_A- , OUT_B+ , OUT_B- , GND) particularly a large current can run through. If these pins are wired incorrectly, an operation error or even worse a destruction of the TB62211FNG may occur.

The logic input pins must be correctly wired, too; otherwise, the TB62211FNG may be damaged due to a current larger than the specified current running through the IC.

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Pin Function

This table is a function explanation from the terminal number 1 to 24.

Pin No.	Pin Name	Function
1	PGND	Motor power ground
2	OUT_B-	B-phase negative driver output
3	PGND	Motor power ground
4	OUT_B+	B-phase positive driver output
5	R _{S_B}	The sink current sensing of B-phase motor coil
6	V_{M}	Motor power supply monitor
7	NC	No-connect
8	V_{CC}	Smoothing filter for logic power supply
9	LGND	Logic ground
10	V_{ref}	Tunes the current level for motor drive
11	OSCM	Oscillator pin for PWM choppers
12	CW/CCW	Motor rotation: forward/reverse
13	MO_OUT	Electric angle monitor
14	D_MODE1	Excitation mode control
15	D_MODE2	Excitation mode control
16	CLK	An electrical angle leads on the rising edge of the clock input. A motor rotation count depends on the input frequency.
17	ENABLE	A-/B-channel output enable
18	RESET	Electric angle reset
19	LGND	Logic ground
20	R _{S_A}	The sink current sensing of A-phase motor coil
21	OUT_A+	A-phase positive driver output
22	PGND	Motor power ground
23	OUT_A-	A-phase negative driver output
24 <	PGND	Motor power ground

CLK Function

The electrical angle leads one by one in the manner of the clocks. The clock signal is reflected to the electrical angle on the rising edge.

CLK Input	Function
Rise	The electrical angle leads by one on the rising edge.
Fall	Remains at the same position.

ENABLE Function

The ENABLE pin controls whether or not to let the current flow through a given phase for a stepper motor drive. This pin serves to select if the motor is stopped in off mode or activated. The pin must be fixed to Low on the power-on or power-down of the TB62211FNG. During power on, once the $V_{\rm M}$ voltage has reached the voltage required to operate the motor, set this to High.

ENABLE Input	Function
Н	Output transistors are enabled (normal operation mode).
L	Output transistors are disabled (high impedance state).

CW/CCW Function

The CW/CCW pin switches rotation direction of stepper motors.

The CW pin outputs the A-phase current 90° behind than the B-phase current.

The CCW pin outputs the A-phase current 90° ahead of the B-phase current.

CW/CCW Input		Function	
Н	Forward (CW)		
L	Reverse (CCW)		\wedge

Excitation Mode Select Function

D_MODE1	D_MODE2	Function
L	4	OSC_M, output transistors are disabled (in Standby mode)
L	Н	Two-phase excitation
Н	L	1-2-phase excitation
Н	У Н	W1-2-phase excitation

RESET Function

The RESET function resets the electrical angle. Always set this to H during power on. Once the V_M voltage has reached the voltage required to operate the motor, release RESET.

RESET Input	Function
L	Normal operation mode
Н	The electrical angle is reset.

The phase current while RESET is applied is shown in the table below. MO_OUT is Low at this time.

Excitation Mode	A-phase Current	B-phase Current
2 Phase	100%	100%
1-2 Phase	100%	100%
W1-2 Phase	71%	71%

Detection Features

(1) Thermal shutdown (TSD)

The thermal shutdown circuit turns off all the outputs when the junction temperature (T_j) exceeds 150°C (typ.). The outputs retain the current states.

The TB62211FNG exits TSD mode and resume normal operation when the TB62211FNG is rebooted or both the D MODE1 and D MODE2 pins are switched to Low.

- (2) Power-ON-resets (PORs) for V_{MR} and V_{CCR} (V_{M} and V_{CC} voltage monitor) The outputs are forced off until V_{M} and V_{CC} reach the rated voltages.
- (3) Over current detection (ISD)

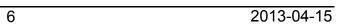
Each phase has an over current detection circuit, which turns off the corresponding outputs when the output current exceeds the shutdown trip threshold (abnormal current more than 2.1A).

The TB62211FNG exits ISD mode and resumes normal operation when the TB62211FNG is rebooted or both the D_MODE1 and D_MODE2 pins are switched to Low.

This circuit provides protection against a short-circuit by temporarily disabling the device. Important notes on this feature will be provided later.

Cautions on Over current Detection (ISD) and Thermal Shutdown (TSD)

- The ISD and TSD circuits are only intended to provide temporary protection against irregular conditions such as an output short-circuit; they do not necessarily guarantee the complete IC safety.
- If the device is used beyond the specified operating ranges, these circuits may not operate properly: then the device may be damaged due to an output short-circuit.
- The ISD circuit is only intended to provide a temporary protection against an output short-circuit. If such a condition persists for a long time, the device may be damaged due to overstress. Over current conditions must be removed immediately by external hardware.



Absolute Maximum Ratings ($T_a = 25$ °C)

Characteristics	Symbol	Rating	Unit
Motor power supply	V _M	40	V
Motor output voltage	V _{OUT}	40	V
Motor output current (Note 1)	I _{OUT}	1.0	A per phase
Logic power supply	V _{CC}	6.0	V
Logic input voltage	V _{IN}	6.0	V
MO output voltage	V _{MO}	6.0	V
MO output sink current	I _{MO}	30.0	mA
V _{ref} reference voltage	V_{ref}	5.0	V (
Power dissipation (Note 2)	P _D	3.125	w
Operating temperature	T _{opr}	-20 to 85	°C
Storage temperature	T _{stg}	-55 to 150	°C
Junction temperature	$T_{j(MAX)}$	150	(),e

Note 1: Perform thermal calculations for the maximum current value under normal conditions. Use the IC at 0.6 A or less per phase. The current value maybe controlled according to the ambient temperature or board conditions.

Note 2: Mounts on the substrate $(T_a = 25^{\circ}C)$

If T_a is over 25°C, derating is required at 25mW/°C.

T_a: Ambient temperature

Topr: Ambient temperature while the TB62211FNG is active.

T_j: Junction temperature while the TB62211FNG is active. The maximum junction temperature is limited by the thermal shutdown (TSD) circuitry.

Because the maximum value of T_i is 120°C, recommended maximum current usage is below 120°C.

Absolute Maximum Ratings

The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.

Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.

The value of even one parameter of the absolute maximum ratings should not be exceeded under any circumstances. The TB62211FNG does not have overvoltage protection. Therefore, the device is damaged if a voltage exceeding its rated maximum is applied.

All voltage ratings including supply voltages must always be followed. The other notes and considerations described later should also be referred to.

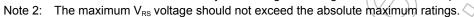
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Operating Ranges ($T_a = 0$ to 85° C)

Characteristics	Symbol	Min	Тур.	Max	Unit	Remarks
Motor power supply	V_{M}	10.0	24.0	38.0	V	-
Motor output current	I _{OUT}	-	0.6	1.0	Α	Per phase (Note 1)
Logic input voltage	$V_{IN(H)}$	2.0	-	5.5	V	Logic high level
Logic input voltage	$V_{IN(L)}$	-0.4	-	1.0	V	Logic low level
MO output voltage	V_{MO}	-	3.3	5.5	V	With a pull-up resistor
Clock input frequency	f _{CLK}	-	-	100	kHz	<u> </u>
Chopper frequency	f _{chop}	40	-	150	kHz	-
V _{ref} reference voltage	V_{ref}	GND	-	3.6	V	-
Voltage across the current-sensing resistor pins	V _{RS}	0.0	±1.0	±1.5	Y	Referenced to the V _M pin (Note 2)

Note 1: The actual maximum current may be limited by the operating environment (operating conditions such as excitation mode or operating duration, or by the surrounding temperature or board heat dissipation). Determine a realistic maximum current by calculating the heat generated under the operating environment.





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Electrical Characteristics 1 ($T_a = 25$ °C, $V_M = 24$ V, unless otherwise specified)

Characterist	ics	Symbol	Test Condition	Min	Тур.	Max	Unit
Digital input	High	$V_{\text{IN(H)}}$	Digital input pins (Note)	2	3.3	5.5	V
voltage	Low	$V_{IN(L)}$	Digital input pins (Note)	-0.4	-	1.0	V
Input hysteresis	voltage	V _{IN(HIS)}	Digital input pins (Note)	100	200	300	mV
Digital input	High	I _{IN(H)}	V _{IN} = 5 V at the digital input pins under test	35	50	75	μΑ
current	Low	I _{IN(L)}	V _{IN} = 0 V at the digital input pins under test	(7)	757	1	μΑ
MO output	High	V _{OH (MO)}	I _{OH} = -24 mA when the output is High	2.4	<u> </u>	-	V
voltage	Low	V _{OL (MO)}	I _{OL} = 24 mA when the output is Low		-	0.5	٧
		I _{M1}	Outputs open, In standby mode (D_MODE1=L, D_MODE2=L)	\\ \ -	2	3	mA
Current consumpti	on	I _{M2}	Outputs open, ENABLE Low	-	3.5))5	mA
		I _{M3}	Outputs open (two-phase excitation)	-	5		mA
Output leakage	High-side	I _{OH}	$V_{RS} = V_{M} = 40 \text{ V}, V_{OUT} = 0 \text{ V}$	-((2	μΑ
current	Low-side	I _{OL}	$V_{RS} = V_M = V_{OUT} = 40 \text{ V}$	2/	<u>)</u>	-	μΑ
Chanel-to-channel differential	current	ΔI_{OUT1}	Channel-to-channel error	5	0	5	%
Output current error relative to the predetermined value		ΔI_{OUT2}	Iout = 1.0 A	-7	0	7	%
R _S pin current		I _{RS}	$V_{RS} = V_M = 24 \text{ V}$	0	-	10	μΑ
Drain-source ON-r of the output transi (upper and lower s	stors	R _{ON(D-S)}	$I_{OUT} = 1.0A, T_j = 25^{\circ}C$	-	1.2	1.5	Ω

Note: $V_{IN}(L \to H)$ is defined as the V_{IN} voltage that causes the outputs to change when a pin under test is gradually raised from 0 V. $V_{IN}(H \to L)$ is defined as the V_{IN} voltage that causes the outputs to change when the pin is then gradually lowered.

The difference between V_{IN} (L \rightarrow H) and V_{IN} (H \rightarrow L) is defined as the input hysteresis.



Electrical Characteristics 2 (T_a = 25°C, V_M = 24 V, unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
V _{ref} input current	I _{ref}	V _{ref} = 3.0 V	-	0	1	μΑ
V _{ref} decay rate	V _{ref} (gain)	V _{ref} = 2.0 V	1/4.8	1/5.0	1/5.2	-
TSD threshold (Note 1)	T _j TSD	-	140	150	170	°C
V _M recovery voltage (Note 2)	V_{MR}	-	7.0	8.0	9.0	V
Supply voltage for internal circuitry (Note 3)	V _{CC}	I _{CC} = 5.0 mA	4.75	5.00	5.25	V

Note 1: Thermal shutdown (TSD) circuitry

When the junction temperature of the device has reached the threshold, the TSD circuitry is tripped, causing the internal reset circuitry to turn off the output transistors.

The TSD circuitry is tripped at a temperature between 140°C (min) and 170°C (max). Once tripped, the TSD circuitry keeps the output transistors off until both the D_MODE1 and D_MODE2 pins are switched to Low or the TB62211FNG is rebooted.

The thermal shutdown circuit is provided to turn off all the outputs when the IC is overheated. For this reason, please avoid using TSD for other purposes.

Note 2: The circuit design has been designed so that electromotive force or leak current from signal input does not occur when V_M voltage is not supplied, even if the logic input signal is input. Even so, regulate logic input signals before resupply of V_M voltage so that the motor does not operate when voltage is reapplied.

Note 3: If the supply voltage for internal circuitry (Vcc) is split with an external resistor and used as V_{ref} input supply voltage, the accuracy of the output current setting will be at ±8% when the V_{cc} output voltage accuracy and the V_{ref} damping ratio accuracy are combined.

Back-EMF

While a motor is rotating, there is a timing at which power is fed back to the power supply. At that timing, the motor current recirculates back to the power supply due to the effect of the motor back-EMF.

If the power supply does not have enough sink capability, the power supply and output pins of the device might rise above the rated voltages. The magnitude of the motor back-EMF varies with usage conditions and motor characteristics. It must be fully verified that there is no risk that the TB62211FNG or other components will be damaged or fail due to the motor back-EMF.

IC Mounting

Do not insert devices in the wrong orientation or incorrectly. Otherwise, it may cause the device breakdown, damage and/or deterioration.

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AC Electrical Characteristics (T_a = 25°C, V_M = 24 V, 6.8 mH/5.7 Ω)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Clock input frequency	f _{CLK}	f _{CR} = 1600 kHz	-	-	100	kHz
Minimum high pulse width of CLK input filter	t _{CLK} (H)	High time of the clock input frequency	300	-	-	ns
Minimum low pulse width of CLK input filter	t _{CLK (L)}	Low time of the clock input frequency	250	-	1	ns
	t _r	-	150_	200	250	ns
Output transistor switching	t _f	- ^ (7	100	150	200	ns
characteristics	t _{pLH} (CLK)	CLK to OUT	<u> </u>	1000	-	ns
	t _{pHL} (CLK)	CLK to OUT	-	1500	-	ns
Blanking time for current spike prevention	t _{BLANK}	I _{OUT} = 1.0 A	200	300	500	ns
OSCM oscillation frequency	f _{CR}	$C_{OSC} = 270 \text{ pF}, R_{OSC} = 3.6 \text{ k}\Omega$	1200	1600	2000	kHz
Chopper frequency range	f _{chop (RANGE)}	$V_M = 24 \text{ V}$, outputs enabled ACTIVE ($I_{OUT} = 1.0 \text{ A}$)	40)-/	150	kHz
Predefined chopper frequency	f_{chop}	Outputs enabled ACTIVE ($I_{OUT} = 1.0 \text{ A}$), $f_{CR} = 1600 \text{ kHz}$	7	100	-	kHz

The timing charts may be simplified for explanatory purpose.

Calculation of the Predefined Output Current

For PWM constant-current control, the TB62211FNG uses a clock generated by the CR oscillator. The peak output current can be set via the current-sensing resistor (R_{RS}) and the reference voltage (V_{ref}), as follows:

$$I_{OUT} = (1 / 5) \times V_{ref}[V] \times (1 / R_{RS}[\Omega])$$

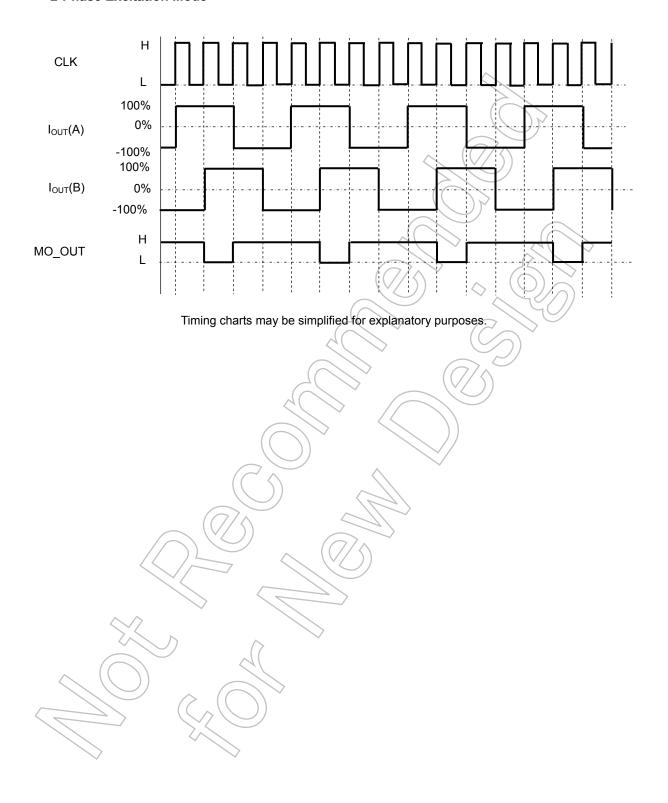
where, 1/5 is the V_{ref} decay rate, $V_{ref (gain)}$. For the value of $V_{ref (gain)}$, see the Electrical Characteristics table.

For example, when $V_{ref} = 0.88$ V, to generate an output current (I_{OUT}) of 0.8 A, R_{RS} is calculated as: $R_{RS} = (V_{ref}/5) / I_{OUT} = (0.88 / 5) / 0.8 = 0.22 \Omega (\ge 0.5 W)$

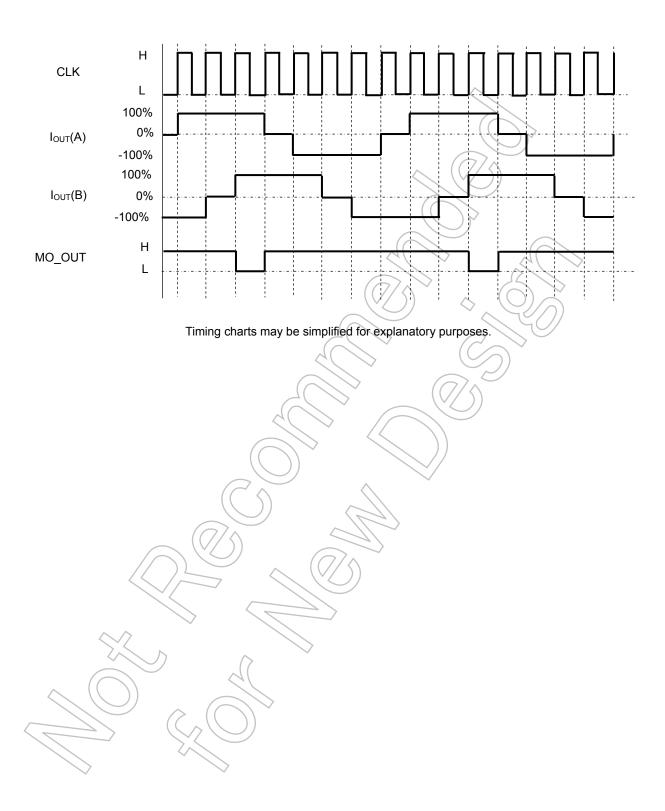


Phase Sequences

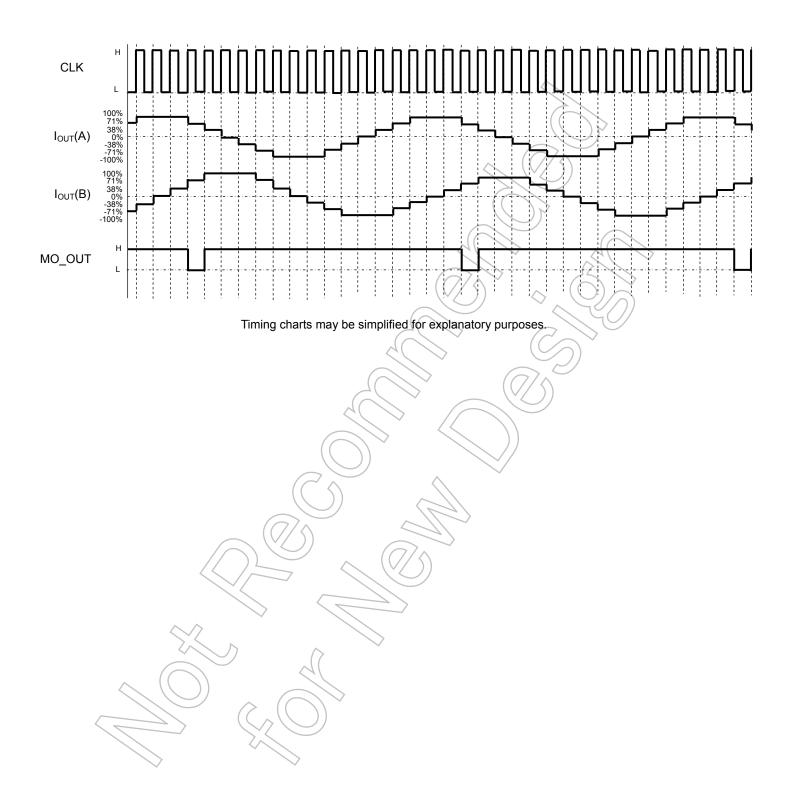
2-Phase Excitation Mode



1-2-Phase Excitation



W1-2-Phase Excitation



Calculation of the OSCM oscillation frequency (chopper reference frequency)

The OSCM oscillating frequency can be approximated using the following equation:

$$f_{CR} = 1 / [0.56 \times C_{OSC} \times (R_{OSC} + 500)]$$

fchop = $f_{CR} / 16$

Where:

 C_{OSC} = Capacitor capacity

Rosc = Resistance

Assigning C_{OSC} = 270 × 10⁻¹² [F], R_{OSC} = 3600 [Ω] to get:

 $f_{CR} = 1.61 \times 10^6 = 1.6 \text{ MHz}$

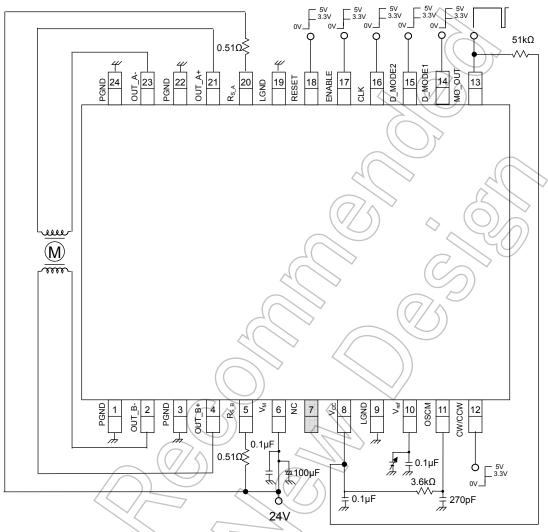
At this time, the chopping frequency fchop is calculated as follows:

 $fchop = f_{CR}/16 = 100 \text{ kHz}$



Application Circuit Example

The values shown in the following figure are typical values. For input conditions, see Operating Ranges.



Note: Bypass capacitors should be added as necessary.

It is recommended to use a single ground plane for the entire board whenever possible, and a grounding method should be considered for efficient heat dissipation.

In cases where mode setting pins are controlled via switches, either pull-down or pull-up resistors should be added to them to avoid floating states.

For a description of the input values, see the output function tables.

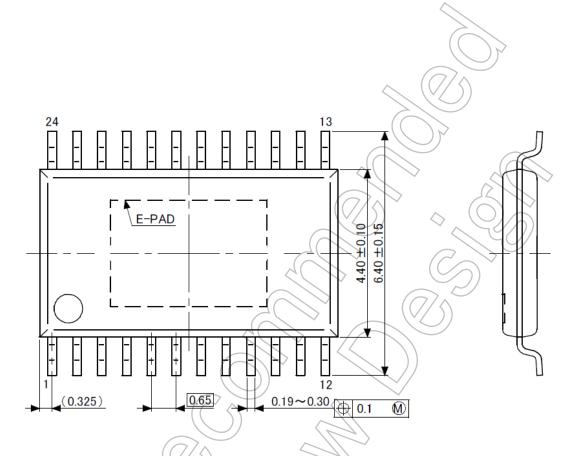
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The IC may be destroyed due to short circuit between output pins, an output pin and the VDD pin, or an output pin and the GND pin. Design an output line, VM line and GND line with great care. Also a low-withstand-voltage device may be destroyed when mounted in the wrong orientation, which causes high-withstanding voltage to be applied to the device.

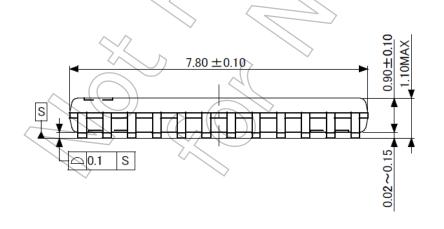
Package Dimensions

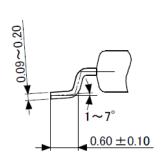
P-HTSSOP24-0508-0.65-001

"Unit: mm"



The heat sink is located on the back side and has dimensions of 2.85 mm \times 4.05 mm.





Notes on Contents

Block Diagrams

Some of the functional blocks, circuits, or constants in the block diagram may be omitted or simplified for explanatory purposes.

Timing Charts

Timing charts may be simplified for explanatory purposes.

Application Circuits

The application circuits shown in this document are provided for reference purposes only. Thorough evaluation is required, especially at the mass production design stage.

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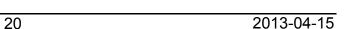
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IC Usage Considerations

Notes on handling of ICs

(1) The absolute maximum ratings of a semiconductor device are a set of ratings that must not be exceeded, even for a moment. Do not exceed any of these ratings.
Exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion.

- (2) Use an appropriate power supply fuse to ensure that a large current does not continuously flow in case of over current and/or IC failure. The IC will fully break down when used under conditions that exceed its absolute maximum ratings, when the wiring is routed improperly or when an abnormal pulse noise occurs from the wiring or load, causing a large current to continuously flow and the breakdown can lead smoke or ignition. To minimize the effects of the flow of a large current in case of breakdown, appropriate settings, such as fuse capacity, fusing time and insertion circuit location, are required.
- (3) If your design includes an inductive load such as a motor coil, incorporate a protection circuit into the design to prevent device malfunction or breakdown caused by the current resulting from the inrush current at power ON or the negative current resulting from the back electromotive force at power OFF. IC breakdown may cause injury, smoke or ignition.
 Use a stable power supply with ICs with built-in protection functions. If the power supply is unstable, the protection function may not operate, causing IC breakdown. IC breakdown may cause injury, smoke or ignition.
- (4) Do not insert devices in the wrong orientation or incorrectly. Make sure that the positive and negative terminals of power supplies are connected properly. Otherwise, the current or power consumption may exceed the absolute maximum rating, and exceeding the rating(s) may cause the device breakdown, damage or deterioration, and may result injury by explosion or combustion. In addition, do not use any device that is applied the current with inserting in the wrong orientation or incorrectly even just one time.
- Carefully select external components (such as inputs and negative feedback capacitors) and load components (such as speakers), for example, power amp and regulator. If there is a large amount of leakage current such as input or negative feedback condenser, the IC output DC voltage will increase. If this output voltage is connected to a speaker with low input withstand voltage, over current or IC failure can cause smoke or ignition. (The over current can cause smoke or ignition from the IC itself.) In particular, please pay attention when using a Bridge Tied Load (BTL) connection type IC that inputs output DC voltage to a speaker directly.



Points to remember on handling of ICs

(1) Over current detection Circuit

Over current detection circuits (referred to as current limiter circuits) do not necessarily protect ICs under all circumstances. If the Over current detection circuits operate against the over current, clear the over current status immediately.

Depending on the method of use and usage conditions, such as exceeding absolute maximum ratings can cause the over current detection circuit to not operate properly or IC breakdown before operation. In addition, depending on the method of use and usage conditions, if over current continues to flow for a long time after operation, the IC may generate heat resulting in breakdown.

(2) Thermal Shutdown Circuit

Thermal shutdown circuits do not necessarily protect ICs under all circumstances. If the thermal shutdown circuits operate against the over temperature, clear the heat generation status immediately. Depending on the method of use and usage conditions, such as exceeding absolute maximum ratings can cause the thermal shutdown circuit to not operate properly or IC breakdown before operation.

(3) Heat Radiation Design

In using an IC with large current flow such as power amp, regulator or driver, please design the device so that heat is appropriately radiated, not to exceed the specified junction temperature (TJ) at any time and condition. These ICs generate heat even during normal use. An inadequate IC heat radiation design can lead to decrease in IC life, deterioration of IC characteristics or IC breakdown. In addition, please design the device taking into considerate the effect of IC heat radiation with peripheral components.

(4) Back-EMF

When a motor rotates in the reverse direction, stops or slows down abruptly, a current flow back to the motor's power supply due to the effect of back-EMF. If the current sink capability of the power supply is small, the device's motor power supply and output pins might be exposed to conditions beyond absolute maximum ratings. To avoid this problem, take the effect of back-EMF into consideration in system design.



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